Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,543	SHIONO ET AL.	
Examiner	Art Unit	
Ahmed M. Farah	3735	

SEARCHED								
Class	Subclass	Date	Examiner					
606	13-16, 27,28	9/27/2007	AF					
607	116,138 / 43	9/27/2007	AF					
128	898	9/27/2007	AF					
600	424,437 443_493	9/27/2007	AF					
73	596, 627- 432	9/27/2007	AF					

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
Interference Search History Printout.		9/27/2007	AF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search; and EAST search: Classification (IS&R); and Text (BRS)	9/27/2007	AF		
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	9/27/2007	AF		
See the attached "Search History."	9/27/2007	AF		